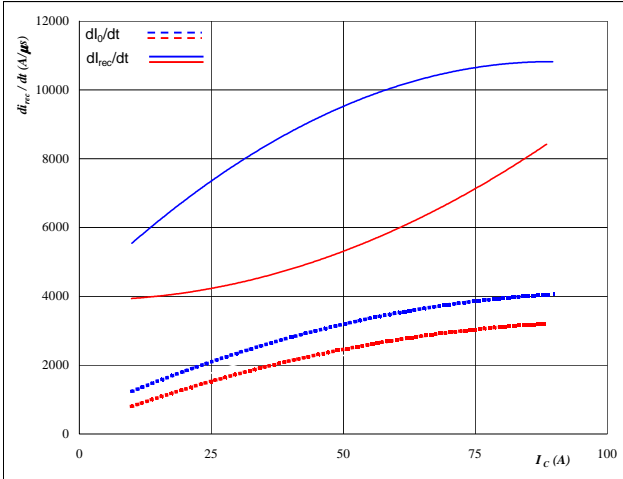


H-Bridge

Figure 17 H-Bridge FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

$$dI_f/dt, dI_{rec}/dt = f(I_C)$$

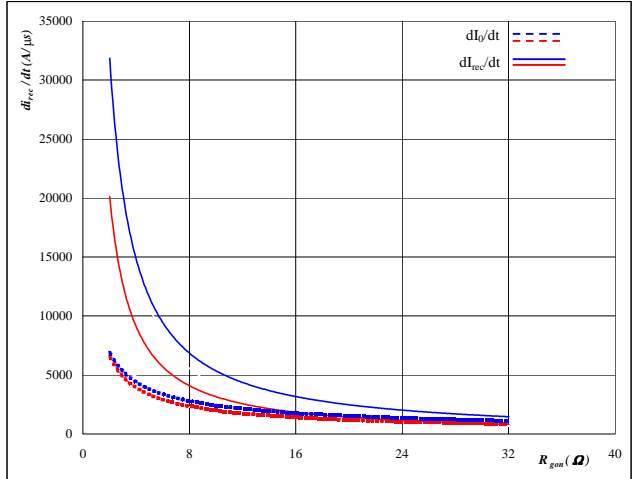


At
 $T_j = 25/126 \text{ } ^\circ\text{C}$
 $V_{CE} = 300 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 8 \text{ } \Omega$

Figure 18 H-Bridge FWD

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$$dI_f/dt, dI_{rec}/dt = f(R_{gon})$$

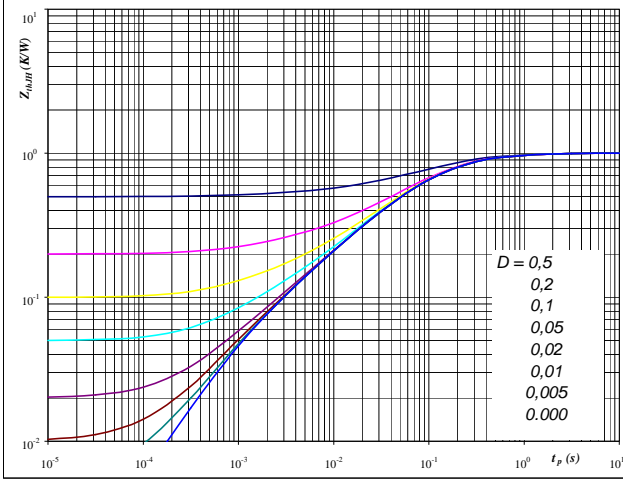


At
 $T_j = 25/126 \text{ } ^\circ\text{C}$
 $V_R = 300 \text{ V}$
 $I_F = 50 \text{ A}$
 $V_{GE} = \pm 15 \text{ V}$

Figure 19 H-Bridge IGBT

IGBT transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At
 $D = t_p / T$
 $R_{thJH} = 1,00 \text{ K/W}$ $R_{thJH} = 1,17 \text{ K/W}$

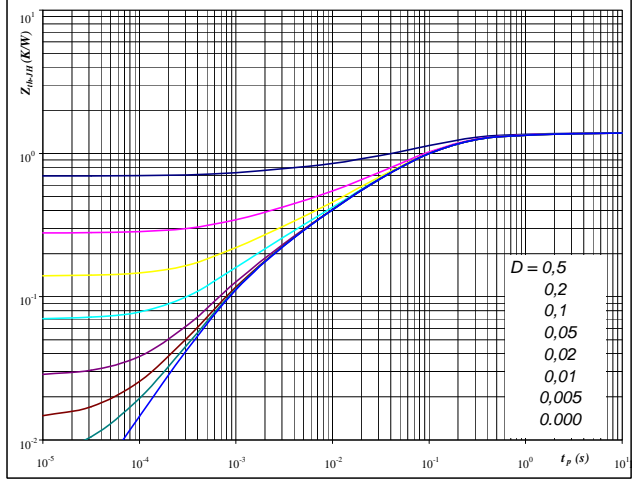
IGBT thermal model values

Phase change interface		Thermal grease	
R (C/W)	Tau (s)	R (C/W)	Tau (s)
0,12	7,7E-01	0,15	7,7E-01
0,46	1,3E-01	0,54	1,3E-01
0,25	4,3E-02	0,29	4,3E-02
0,12	9,4E-03	0,14	9,4E-03
0,04	1,2E-03	0,05	1,2E-03

Figure 20 H-Bridge FWD

FWD transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At
 $D = t_p / T$
 $R_{thJH} = 1,39 \text{ K/W}$ $R_{thJH} = 1,64 \text{ K/W}$

FWD thermal model values

Phase change interface		Thermal grease	
R (C/W)	Tau (s)	R (C/W)	Tau (s)
0,04	4,0E+00	0,04	4,0E+00
0,09	8,3E-01	0,10	8,3E-01
0,56	1,3E-01	0,65	1,3E-01
0,40	3,6E-02	0,47	3,6E-02
0,20	7,3E-03	0,24	7,3E-03
0,12	1,1E-03	0,14	1,1E-03

H-Bridge

Figure 21 H-Bridge IGBT

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

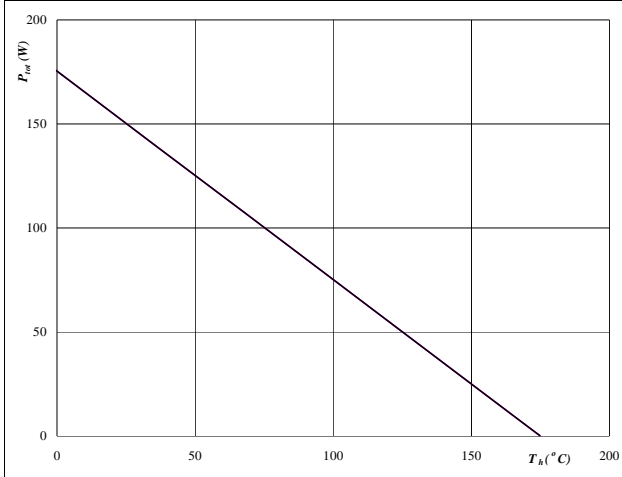

At
 $T_j = 175$ °C

Figure 22 H-Bridge IGBT

Collector current as a function of heatsink temperature

$$I_C = f(T_h)$$

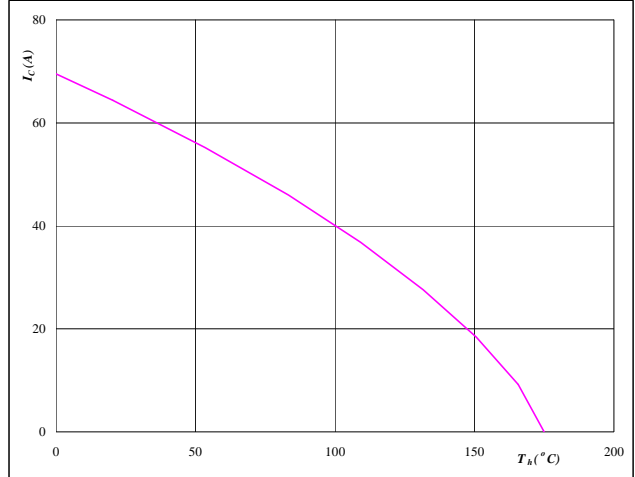

At
 $T_j = 175$ °C
 $V_{GE} = 15$ V

Figure 23 H-Bridge FWD

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

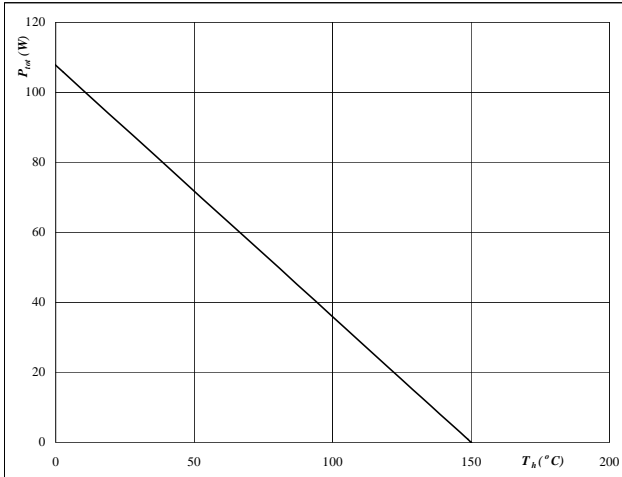
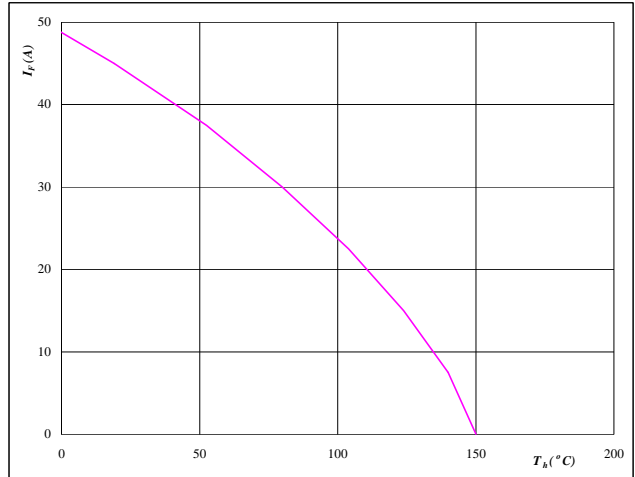

At
 $T_j = 150$ °C

Figure 24 H-Bridge FWD

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$

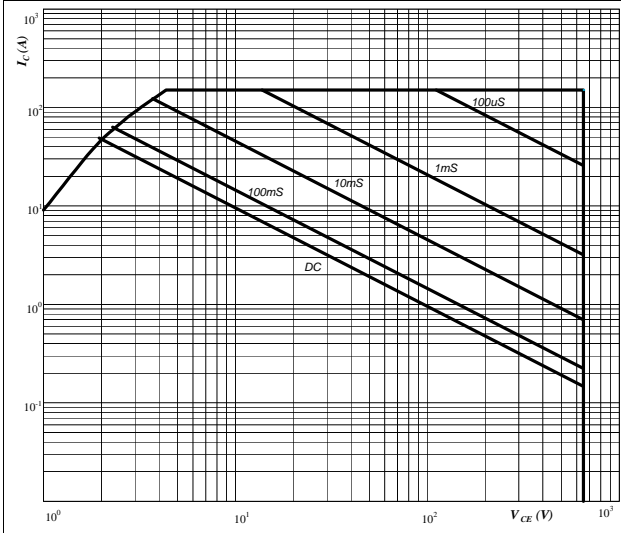

At
 $T_j = 150$ °C

H-Bridge

Figure 25 H-Bridge IGBT

Safe operating area as a function of collector-emitter voltage

$$I_C = f(V_{CE})$$

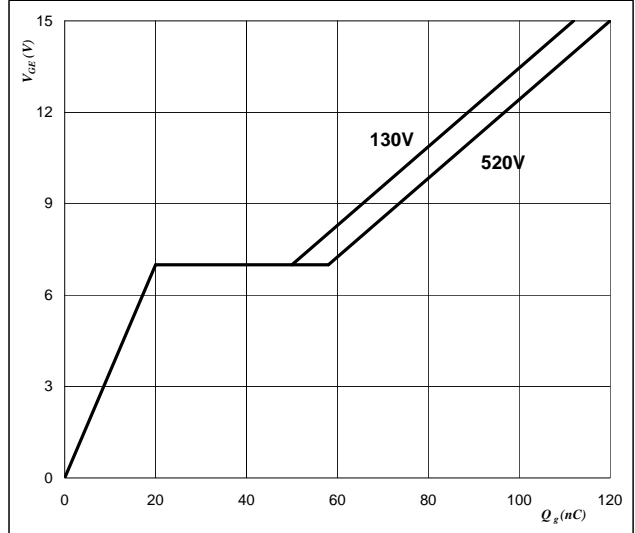


At
 D = single pulse
 $T_h = 80$ °C
 $V_{GE} = \pm 15$ V
 $T_j = T_{jmax}$ °C

Figure 26 H-Bridge IGBT

Gate voltage vs Gate charge

$$V_{GE} = f(Q_{GE})$$

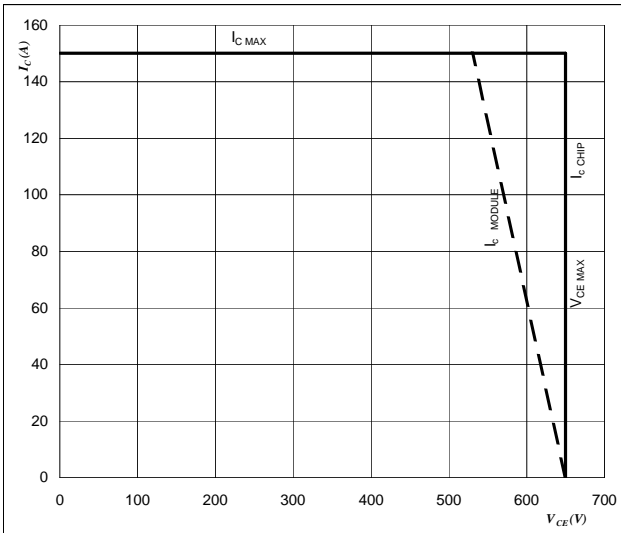


At
 $I_C = 50$ A

Figure 29 H-Bridge IGBT

Reverse bias safe operating area

$$I_C = f(V_{CE})$$



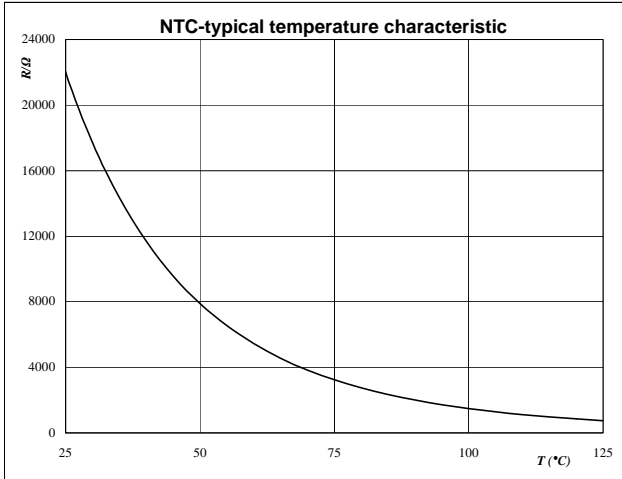
At
 $T_j = T_{jmax} - 25$ °C

Switching mode : 3phase SPWM

Thermistor

Figure 1 Thermistor

Typical NTC characteristic
as a function of temperature

 $R_T = f(T)$

Figure 2 Thermistor

Typical NTC resistance values

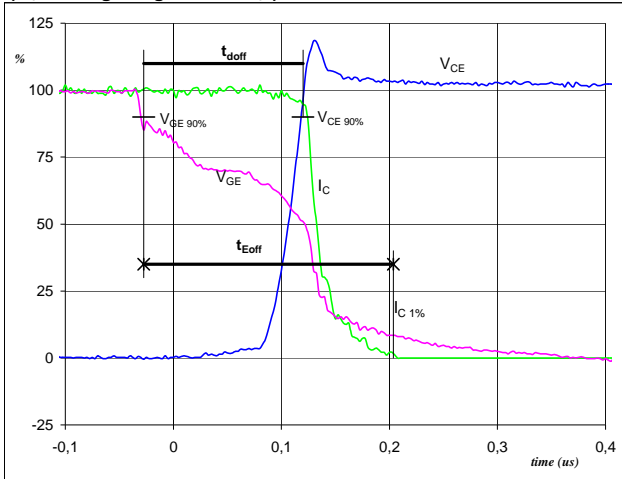
$$R(T) = R_{25} \cdot e^{\left(B_{25/100} \left(\frac{1}{T} - \frac{1}{T_{25}} \right) \right)} \quad [\Omega]$$

Switching Definitions H-Bridge

General conditions

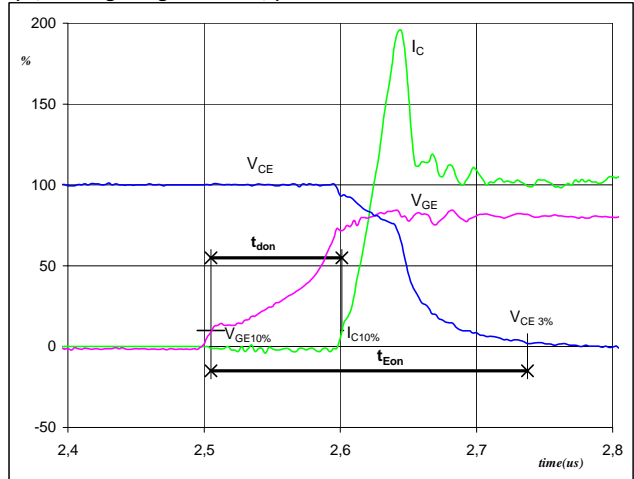
T_j	=	125 °C
R_{gon}	=	8 Ω
R_{goff}	=	8 Ω

Figure 1 H-Bridge IGBT

Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
(t_{Eoff} = integrating time for E_{off})


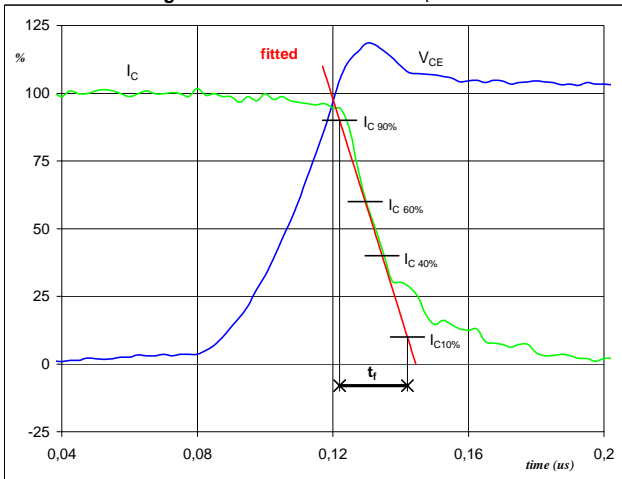
$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	300	V
$I_C(100\%) =$	50	A
$t_{doff} =$	0,15	μ s
$t_{Eoff} =$	0,23	μ s

Figure 2 H-Bridge IGBT

Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
(t_{Eon} = integrating time for E_{on})


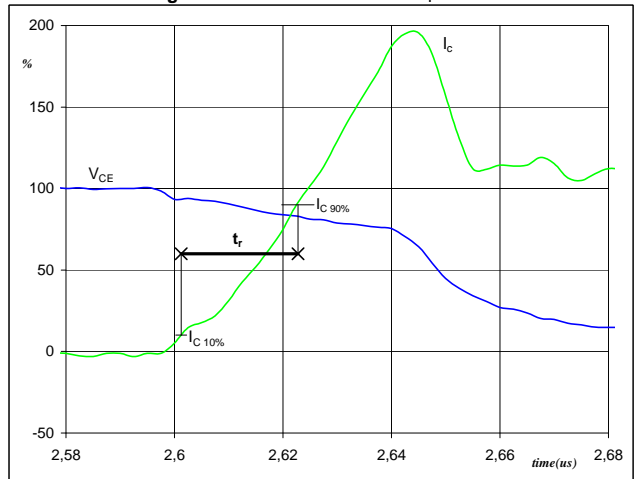
$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	300	V
$I_C(100\%) =$	50	A
$t_{don} =$	0,10	μ s
$t_{Eon} =$	0,23	μ s

Figure 3 H-Bridge IGBT

Turn-off Switching Waveforms & definition of t_f


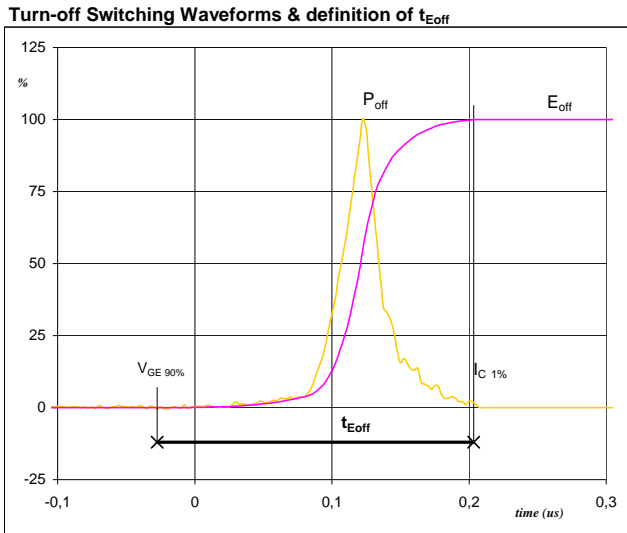
$V_C(100\%) =$	300	V
$I_C(100\%) =$	50	A
$t_f =$	0,024	μ s

Figure 4 H-Bridge IGBT

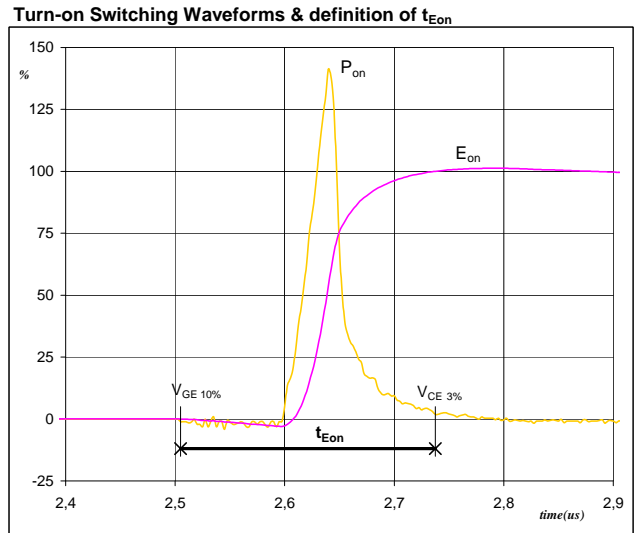
Turn-on Switching Waveforms & definition of t_r


$V_C(100\%) =$	300	V
$I_C(100\%) =$	50	A
$t_r =$	0,021	μ s

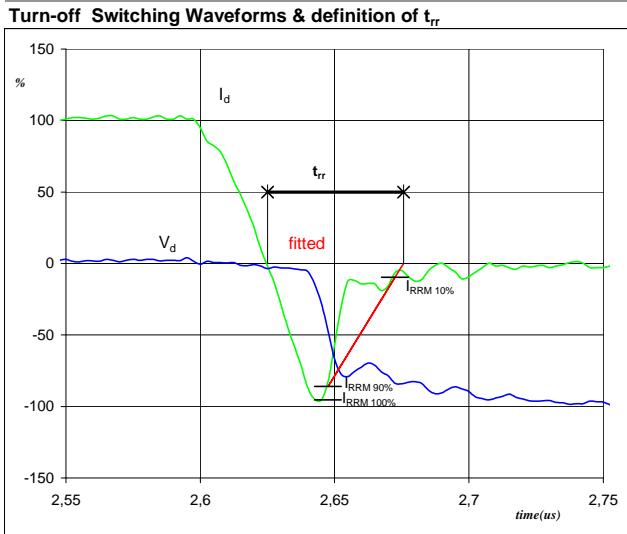
Switching Definitions H-Bridge

Figure 5 H-Bridge IGBT


$P_{off} (100\%) = 15,12 \text{ kW}$
 $E_{off} (100\%) = 0,57 \text{ mJ}$
 $t_{Eoff} = 0,23 \text{ }\mu\text{s}$

Figure 6 H-Bridge IGBT


$P_{on} (100\%) = 15,12 \text{ kW}$
 $E_{on} (100\%) = 0,79 \text{ mJ}$
 $t_{Eon} = 0,23 \text{ }\mu\text{s}$

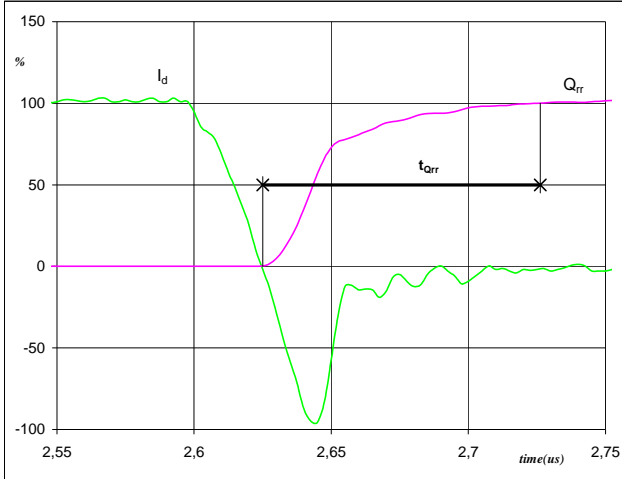
Figure 7 H-Bridge IGBT


$V_d (100\%) = 300 \text{ V}$
 $I_d (100\%) = 50 \text{ A}$
 $I_{RRM} (100\%) = -49 \text{ A}$
 $t_{rr} = 0,05 \text{ }\mu\text{s}$

Switching Definitions H-Bridge

Figure 8 H-Bridge FWD

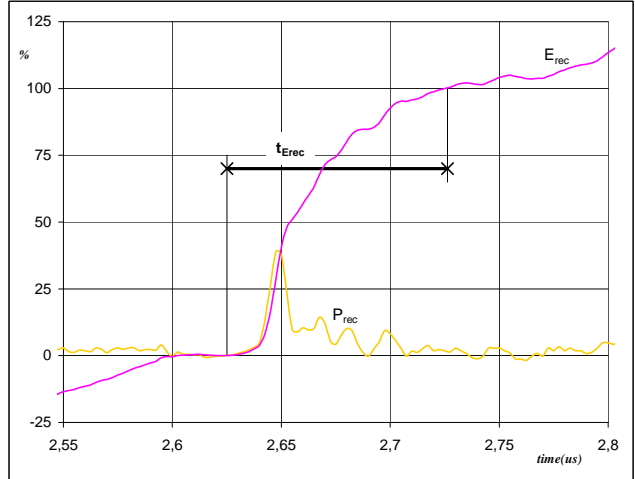
Turn-on Switching Waveforms & definition of t_{Qrr}
 (t_{Qrr} = integrating time for Q_{rr})



I_d (100%) =	50	A
Q_{rr} (100%) =	1,10	μC
t_{Qrr} =	0,10	μs

Figure 9 H-Bridge FWD

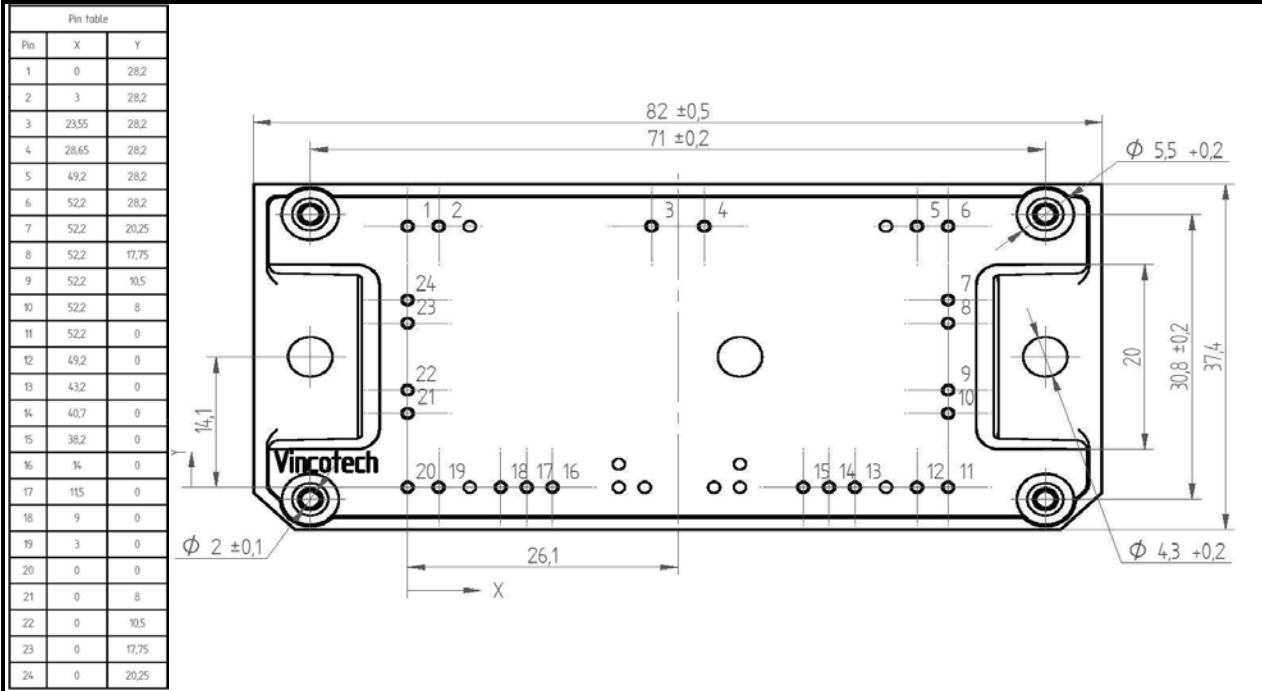
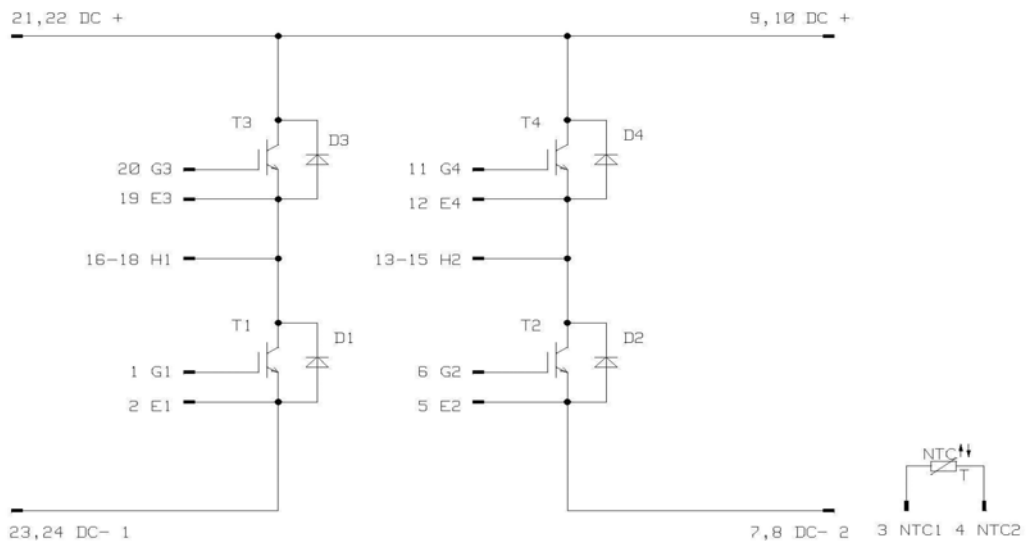
Turn-on Switching Waveforms & definition of t_{Erec}
 (t_{Erec} = integrating time for E_{rec})



P_{rec} (100%) =	15,12	kW
E_{rec} (100%) =	0,13	mJ
t_{Erec} =	0,10	μs

Ordering Code and Marking - Outline - Pinout
Ordering Code & Marking

Version	Ordering Code	in DataMatrix as	in packaging barcode as
without thermal paste 12mm housing	10-FY064PA050SG10-M582F08	M582F08	M582F08

Outline

Pinout


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